


<b>Search Notes</b>  	<b>Application/Control No.</b>  10824874	<b>Applicant(s)/Patent Under Reexamination</b>  BALLEW ET AL.
	<b>Examiner</b>  Geib, Benjamin	<b>Art Unit</b>  2181

SEARCHED			
Class	Subclass	Date	Examiner
712	10	8/26/2010	BPG
710	316	8/26/2010	BPG

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search	8/26/2010	BPG
NPL search (IEEE Xplore and Google Scholar)	8/26/2010	BPG
Inventor name search	8/26/2010	BPG

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
712	10	8/26/2010	BPG

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